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Nonvolatile Memory, Dual 1024-Position Digital Potentiometer

Data Sheet AD5235

FEATURES

Dual-channel, 1024-position resolution
25 kΩ, 250 kΩ nominal resistance
Maximum ±8% nominal resistor tolerance error
Low temperature coefficient: 35 ppm/°C
2.7 V to 5 V single supply or ±2.5 V dual supply
SPI-compatible serial interface
Nonvolatile memory stores wiper settings
Power-on refreshed with EEMEM settings
Permanent memory write protection
Resistance tolerance stored in EEMEM
26 bytes extra nonvolatile memory for user-defined information
1M programming cycles
100-year typical data retention

APPLICATIONS

DWDM laser diode driver, optical supervisory systems
Mechanical potentiometer replacement
Instrumentation: gain, offset adjustment
Programmable voltage-to-current conversion
Programmable filters, delays, time constants
Programmable power supply
Low resolution DAC replacement
Sensor calibration

GENERAL DESCRIPTION

The AD5235 is a dual-channel, nonvolatile memory, digitally controlled potentiometer with 1024-step resolution, offering guaranteed maximum low resistor tolerance error of ±8%. The device performs the same electronic adjustment function as a mechanical potentiometer with enhanced resolution, solid state reliability, and superior low temperature coefficient performance. The versatile programming of the AD5235 via an SPI*-compatible serial interface allows 16 modes of operation and adjustment including scratchpad programming, memory storing and restoring, increment/decrement, ±6 dB/step log taper adjustment, wiper setting readback, and extra EEMEM¹ for user-defined information such as memory data for other components, look-up table, or system identification information.

FUNCTIONAL BLOCK DIAGRAM

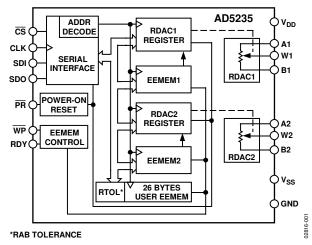


Figure 1.

In the scratchpad programming mode, a specific setting can be programmed directly to the RDAC² register, which sets the resistance between Terminal W and Terminal A and Terminal W and Terminal B. This setting can be stored into the EEMEM and is restored automatically to the RDAC register during system power-on.

The EEMEM content can be restored dynamically or through external \overline{PR} strobing, and a \overline{WP} function protects EEMEM contents. To simplify the programming, the independent or simultaneous linear-step increment or decrement commands can be used to move the RDAC wiper up or down, one step at a time. For logarithmic ± 6 dB changes in the wiper setting, the left or right bit shift command can be used to double or halve the RDAC wiper setting.

The AD5235 patterned resistance tolerance is stored in the EEMEM. The actual end-to-end resistance can, therefore, be known by the host processor in readback mode. The host can execute the appropriate resistance step through a software routine that simplifies open-loop applications as well as precision calibration and tolerance matching applications.

The AD5235 is available in a thin, 16-lead TSSOP package. The part is guaranteed to operate over the extended industrial temperature range of -40° C to $+85^{\circ}$ C.

¹ The terms nonvolatile memory and EEMEM are used interchangeably.

² The terms digital potentiometer and RDAC are used interchangeably.

AD5235* PRODUCT PAGE QUICK LINKS

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COMPARABLE PARTS 🖳

View a parametric search of comparable parts.

EVALUATION KITS

· AD5235 Evaluation Board

DOCUMENTATION

Application Notes

- AN-1291: Digital Potentiometers: Frequently Asked Questions
- AN-579: Versatile Programmable Amplifiers Using Digital Potentiometers with Nonvolatile Memory
- AN-580: Programmable Oscillator Uses Digital Potentiometers
- AN-582: Resolution Enhancements of Digital Potentiometers with Multiple Devices
- AN-627: AD5235 Evaluation Kit User Manual
- AN-686: Implementing an I²C[®] Reset

Data Sheet

- · AD5235-DSCC: Military Data Sheet
- · AD5235-EP: Enhanced Product Data Sheet
- AD5235: Nonvolatile Memory, Dual 1024-Position Digital Potentiometer Data Sheet

User Guides

 UG-258: Evaluation Board for the AD5235 Digital Potentiometer

SOFTWARE AND SYSTEMS REQUIREMENTS 🖵

- Digital Potentiometer Linux Driver
- AD5235 FMC-SDP Interposer & Evaluation Board / Xilinx KC705 Reference Design
- · BeMicro FPGA Project for AD5235 with Nios driver

TOOLS AND SIMULATIONS

AD5235 IBIS Model

DESIGN RESOURCES \Box

- AD5235 Material Declaration
- PCN-PDN Information
- · Quality And Reliability
- · Symbols and Footprints

DISCUSSIONS 🖳

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SAMPLE AND BUY 🖳

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TECHNICAL SUPPORT 🖵

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DOCUMENT FEEDBACK 🖳

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TABLE OF CONTENTS

Features	l
Applications	1
General Description	1
Functional Block Diagram	1
Revision History	3
Specifications	4
Electrical Characteristics—25 k Ω , 250 k Ω Versions	4
Interface Timing and EEMEM Reliability Characteristics– 25 k Ω , 250 k Ω Versions	
Absolute Maximum Ratings	8
ESD Caution	8
Pin Configuration and Function Descriptions	9
Typical Performance Characteristics	10
Test Circuits	14
Theory of Operation	16
Scratchpad and EEMEM Programming	16
Basic Operation	16
EEMEM Protection	17
Digital Input and Output Configuration	17
Serial Data Interface	17
Daisy-Chain Operation	18
Terminal Voltage Operating Range	18
Advanced Control Modes	20
RDAC Structure	21

Programming the Variable Resistor
Programming the Potentiometer Divider
Programming Examples
EVAL-AD5235SDZ Evaluation Kit
Applications Information
Bipolar Operation from Dual Supplies24
Gain Control Compensation
High Voltage Operation24
DAC24
Bipolar Programmable Gain Amplifier25
10-Bit Bipolar DAC25
Programmable Voltage Source with Boosted Output 25
Programmable Current Source
Programmable Bidirectional Current Source
Programmable Low-Pass Filter
Programmable Oscillator
Optical Transmitter Calibration with ADN284128
Resistance Scaling
Resistance Tolerance, Drift, and Temperature Coefficient Mismatch Considerations
RDAC Circuit Simulation Model29
Outline Dimensions
Ordering Guide30

REVISION HISTORY

6/12—Rev. E to Rev. F
Changes to Table 1 Conditions
4/11—Rev. D to Rev. E
Changes to Figure 1211
4/11—Rev. C to Rev. D
Changes to EEMEM Performance
4/09—Rev. B to Rev. C
Changes to Figure 1
Figure 42
Changes to Rheostat Operations Section
Changes to Crueffing Guide

7/04—Rev. A to Rev. B

Updated Formatting	Universal
Edits to Features, General Description, and Block Diagram	ram 1
Changes to Specifications	3
Replaced Timing Diagrams	6
Changes to Absolute Maximum Ratings	7
Changes to Pin Function Descriptions	8
Changes to Typical Performance Characteristics	9
Additional Test Circuit (Figure 36)	9
Edits to Theory of Operation	
Edits to Applications	
Updated Outline Dimensions	
8/02—Rev. 0 to Rev. A	
Change to Features and General Description	1
Change to Specifications	2
Change to Calculating Actual End-to-End Terminal	
Resistance Section	14

SPECIFICATIONS

ELECTRICAL CHARACTERISTICS—25 $k\Omega$, 250 $k\Omega$ VERSIONS

 $V_{DD} = 2.7 \text{ V to } 5.5 \text{ V, } V_{SS} = 0 \text{ V; } V_{DD} = 2.5 \text{ V, } V_{SS} = -2.5 \text{ V, } V_{A} = V_{DD} \text{, } V_{B} = V_{SS}, -40 ^{\circ}\text{C} < T_{A} < +85 ^{\circ}\text{C, unless otherwise noted.}$

These specifications apply to versions with a date code 1209 or later.

Table 1.

Parameter	Symbol	Conditions	Min	Typ ¹	Max	Unit
DC CHARACTERISTICS—RHEOSTAT MODE (All RDACs)						
Resistor Differential Nonlinearity ²	R-DNL	R _{WB}	-1		+1	LSB
Resistor Integral Nonlinearity ²	R-INL	R _{WB}	-2		+2	LSB
Nominal Resistor Tolerance	ΔR _{AB} /R _{AB}		-8		+8	%
Resistance Temperature Coefficient	$(\Delta R_{AB}/R_{AB})/\Delta T \times 10^6$			35		ppm/°C
Wiper Resistance	Rw	$I_W = 1 \text{ V/R}_{WB}$, code = midscale				
		$V_{DD} = 5 V$		30	60	Ω
		$V_{DD} = 3 V$		50		Ω
Nominal Resistance Match	R _{AB1} /R _{AB2}			±0.1		%
DC CHARACTERISTICS— POTENTIOMETER DIVIDER MODE (All RDACs)						
Resolution	N				10	Bits
Differential Nonlinearity ³	DNL		-1		+1	LSB
Integral Nonlinearity ³	INL		-1		+1	LSB
Voltage Divider Temperature Coefficient	$(\Delta V_W/V_W)/\Delta T \times 10^6$	Code = midscale		15		ppm/°C
Full-Scale Error	V _{WFSE}	Code = full scale	-6		0	LSB
Zero-Scale Error	V _{WZSE}	Code = zero scale	0		4	LSB
RESISTOR TERMINALS						
Terminal Voltage Range⁴	V_A , V_B , V_W		V_{SS}		V_{DD}	V
Capacitance Ax, Bx⁵	C _A , C _B	f = 1 MHz, measured to GND, code = midscale		11		pF
Capacitance Wx⁵	Cw	f = 1 MHz, measured to GND, code = midscale		80		pF
Common-Mode Leakage Current ^{5, 6}	Ісм	$V_W = V_{DD}/2$		0.01	±1	μΑ
DIGITAL INPUTS AND OUTPUTS						
Input Logic High	V _{IH}	With respect to GND, $V_{DD} = 5 \text{ V}$	2.4			V
Input Logic Low	VIL	With respect to GND, $V_{DD} = 5 \text{ V}$			0.8	V
Input Logic High	V _{IH}	With respect to GND, $V_{DD} = 3 \text{ V}$	2.1			V
Input Logic Low	VIL	With respect to GND, $V_{DD} = 3 \text{ V}$			0.6	V
Input Logic High	V _{IH}	With respect to GND, $V_{DD} = +2.5 \text{ V}$, $V_{SS} = -2.5 \text{ V}$	2.0			V
Input Logic Low	V _{IL}	With respect to GND, $V_{DD} = +2.5 \text{ V}$, $V_{SS} = -2.5 \text{ V}$			0.5	V
Output Logic High (SDO, RDY)	Vон	$R_{PULL-UP} = 2.2 \text{ k}\Omega \text{ to 5 V (see}$ Figure 38)	4.9			V
Output Logic Low	VoL	I _{OL} = 1.6 mA, V _{LOGIC} = 5 V (see Figure 38)			0.4	V
Input Current	I _{IL}	$V_{IN} = 0 \text{ V or } V_{DD}$			±1	μΑ
Input Capacitance ⁵	CIL			5		pF

Parameter	Symbol	Conditions	Min	Typ ¹	Max	Unit
POWER SUPPLIES						
Single-Supply Power Range	V_{DD}	$V_{SS} = 0 V$	2.7		5.5	V
Dual-Supply Power Range	V _{DD} /V _{SS}		±2.25		±2.75	V
Positive Supply Current	I _{DD}	$V_{IH} = V_{DD}$ or $V_{IL} = GND$		2	5	μΑ
Negative Supply Current	Iss	$V_{DD} = +2.5 \text{ V}, V_{SS} = -2.5 \text{ V}$				
		$V_{IH} = V_{DD}$ or $V_{IL} = GND$	-4	-2		μΑ
EEMEM Store Mode Current	I _{DD} (store)	$V_{IH} = V_{DD}$ or $V_{IL} = GND$, $V_{SS} = GND$, $I_{SS} \approx 0$		2		mA
	Iss (store)	$V_{DD} = +2.5 \text{ V}, V_{SS} = -2.5 \text{ V}$		-2		mA
EEMEM Restore Mode Current ⁷	I _{DD} (restore)	$V_{IH} = V_{DD}$ or $V_{IL} = GND$, $V_{SS} = GND$, $I_{SS} \approx 0$		320		μΑ
	I _{SS} (restore)	$V_{DD} = +2.5 \text{ V}, V_{SS} = -2.5 \text{ V}$		-320		μΑ
Power Dissipation ⁸	P _{DISS}	$V_{IH} = V_{DD}$ or $V_{IL} = GND$		10	30	μW
Power Supply Sensitivity⁵	Pss	$\Delta V_{DD} = 5 V \pm 10\%$		0.006	0.01	%/%
DYNAMIC CHARACTERISTICS ^{5, 9}						
Bandwidth	BW	-3 dB, $R_{AB} = 25 \text{ k}\Omega/250 \text{ k}\Omega$		125/12		kHz
Total Harmonic Distortion	THD _w	$V_A = 1 \text{ V rms}, V_B = 0 \text{ V},$ f = 1 kHz, code = midscale				
		$R_{AB} = 25 \text{ k}\Omega$		0.009		%
		$R_{AB} = 250 \text{ k}\Omega$		0.035		%
V _W Settling Time	ts	$V_A = V_{DD}$, $V_B = 0$ V, $V_W = 0.50\%$ error band, from zero scale to midscale				
		$R_{AB} = 25 \text{ k}\Omega$		4		μs
		$R_{AB} = 250 \text{ k}\Omega$		36		μs
Resistor Noise Density	e _{N_wB}	$R_{AB} = 25 \text{ k}\Omega/250 \text{ k}\Omega$		20/64		nV/√H
Crosstalk (C _{W1} /C _{W2})	Ст	$V_{A1} = V_{DD}$, $V_{B1} = V_{SS}$, measured V_{W2} with V_{W1} making full-scale change, $R_{AB} = 25 \text{ k}\Omega/250 \text{ k}\Omega$		30/60		nV-s
Analog Crosstalk	Ста	$V_{AB2} = 5 \text{ V p-p, f} = 1 \text{ kHz, measured}$ V_{W1} , Code 1 = midscale, Code 2 = full scale, $R_{AB} = 25 \text{ k}\Omega/250 \text{ k}\Omega$		-110/-100		dB

 $^{^{1}}$ Typicals represent average readings at 25°C and V_{DD} = 5 V. 2 Resistor position nonlinearity error (R-INL) is the deviation from an ideal value measured between the maximum resistance and the minimum resistance wiper

positions. R-DNL measures the relative step change from ideal between successive tap positions. $I_{WB} = (V_{DD} - 1)/R_{WB}$ (see Figure 27).

3 INL and DNL are measured at V_{W} with the RDAC configured as a potentiometer divider similar to a voltage output DAC. $V_{A} = V_{DD}$ and $V_{B} = V_{SS}$. DNL specification limits of ±1 LSB maximum are guaranteed monotonic operating conditions (see Figure 28).

⁴ Resistor Terminal A, Resistor Terminal B, and Resistor Terminal W have no limitations on polarity with respect to each other. Dual-supply operation enables groundreferenced bipolar signal adjustment.

⁵ Guaranteed by design and not subject to production test.

⁶ Common-mode leakage current is a measure of the dc leakage from any Terminal A, Terminal B, or Terminal W to a common-mode bias level of V_{DD}/2.

⁷ EEMEM restore mode current is not continuous. Current is consumed while EEMEM locations are read and transferred to the RDAC register.

⁸ P_{DISS} is calculated from $(I_{DD} \times V_{DD}) + (I_{SS} \times V_{SS})$.

 $^{^{9}}$ All dynamic characteristics use $V_{DD} = +2.5 \text{ V}$ and $V_{SS} = -2.5 \text{ V}$.

INTERFACE TIMING AND EEMEM RELIABILITY CHARACTERISTICS—25 k Ω , 250 k Ω VERSIONS

Guaranteed by design and not subject to production test. See the Timing Diagrams section for the location of measured values. All input control voltages are specified with t_R = t_F = 2.5 ns (10% to 90% of 3 V) and timed from a voltage level of 1.5 V. Switching characteristics are measured using both $V_{\rm DD}$ = 2.7 V and $V_{\rm DD}$ = 5 V.

Table 2.

Parameter	Symbol	Conditions	Min	Typ ¹	Max	Unit
Clock Cycle Time (t _{CYC})	t ₁		20			ns
CS Setup Time	t ₂		10			ns
CLK Shutdown Time to \overline{CS} Rise	t ₃		1			t _{CYC}
Input Clock Pulse Width	t4, t5	Clock level high or low	10			ns
Data Setup Time	t ₆	From positive CLK transition	5			ns
Data Hold Time	t ₇	From positive CLK transition	5			ns
CS to SDO-SPI Line Acquire	t ₈				40	ns
CS to SDO-SPI Line Release	t ₉				50	ns
CLK to SDO Propagation Delay ²	t ₁₀	$R_P = 2.2 \text{ k}\Omega, C_L < 20 \text{ pF}$			50	ns
CLK to SDO Data Hold Time	t ₁₁	$R_P = 2.2 \text{ k}\Omega$, $C_L < 20 \text{ pF}$	0			ns
CS High Pulse Width ³	t ₁₂		10			ns
CS High to CS High ³	t ₁₃		4			tcyc
RDY Rise to CS Fall	t ₁₄		0			ns
CS Rise to RDY Fall Time	t ₁₅			0.15	0.3	ms
Store EEMEM Time ^{4, 5}	t ₁₆	Applies to Instructions 0x2, 0x3		15	50	ms
Read EEMEM Time⁴	t ₁₆	Applies to Instructions 0x8, 0x9, 0x10		7	30	μs
CS Rise to Clock Rise/Fall Setup	t ₁₇		10			ns
Preset Pulse Width (Asynchronous) ⁶	t _{PRW}		50			ns
Preset Response Time to Wiper Setting ⁶	t _{PRESP}	PR pulsed low to refresh wiper positions		30		μs
Power-On EEMEM Restore Time ⁶	t _{EEMEM}			30		μs
FLASH/EE MEMORY RELIABILITY						
Endurance ⁷		T _A = 25°C		1		MCycles
			100			kCycles
Data Retention ⁸				100		Years

¹ Typicals represent average readings at 25°C and $V_{DD} = 5 \text{ V}$.

 $^{^2}$ Propagation delay depends on the value of $V_{\text{DD}},\,R_{\text{PULL-UP}},$ and $C_{\text{L}}.$

 $^{^{\}rm 3}$ Valid for commands that do not activate the RDY pin.

 $^{^4}$ The RDY pin is low only for Instruction 2, Instruction 3, Instruction 8, Instruction 9, Instruction 10, and the \overline{PR} hardware pulse: CMD_8 ~ 20 μs; CMD_9, CMD_10 ~ 7 μs; CMD_2, CMD_3 ~ 15 ms; \overline{PR} hardware pulse ~ 30 μs.

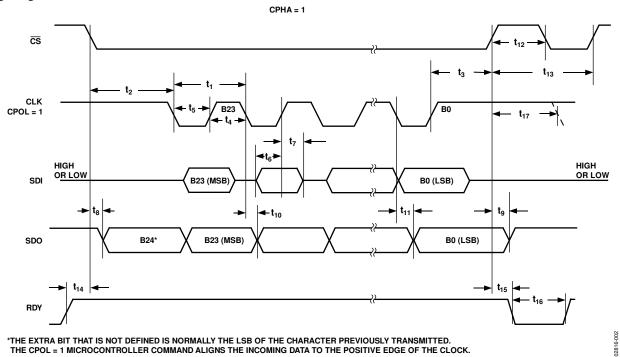
⁵ Store EEMEM time depends on the temperature and EEMEM writes cycles. Higher timing is expected at a lower temperature and higher write cycles.

⁶ Not shown in Figure 2 and Figure 3.

⁷ Endurance is qualified to 100,000 cycles per JEDEC Standard 22, Method A117 and measured at -40°C, +25°C, and +85°C.

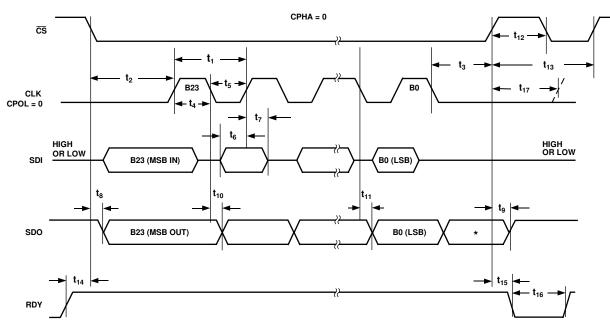
⁸ Retention lifetime equivalent at junction temperature (T₂) = 85°C per JEDEC Standard 22, Method A117. Retention lifetime based on an activation energy of 1 eV derates with junction temperature in the Flash/EE memory.

Timing Diagrams



'THE EXTRA BIT THAT IS NOT DEFINED IS NORMALLY THE LSB OF THE CHARACTER PREVIOUSLY TRANSMITTED. THE CPOL = 1 MICROCONTROLLER COMMAND ALIGNS THE INCOMING DATA TO THE POSITIVE EDGE OF THE CLOCK.

Figure 2. CPHA = 1 Timing Diagram



*THE EXTRA BIT THAT IS NOT DEFINED IS NORMALLY THE MSB OF THE CHARACTER JUST RECEIVED. THE CPOL = 0 MICROCONTROLLER COMMAND ALIGNS THE INCOMING DATA TO THE POSITIVE EDGE OF THE CLOCK.

Figure 3. CPHA = 0 Timing Diagram

02816-003

ABSOLUTE MAXIMUM RATINGS

 $T_A = 25$ °C, unless otherwise noted.

Table 3.

Tubic 3.						
Parameter	Rating					
V _{DD} to GND	-0.3 V to +7 V					
V _{SS} to GND	+0.3 V to -7 V					
V_{DD} to V_{SS}	7 V					
V_A , V_B , V_W to GND	$V_{SS} - 0.3 \text{ V to } V_{DD} + 0.3 \text{ V}$					
I _A , I _B , I _W						
Pulsed ¹	±20 mA					
Continuous	±2 mA					
Digital Input and Output Voltage to GND	$-0.3 \text{ V to V}_{DD} + 0.3 \text{ V}$					
Operating Temperature Range ²	-40°C to +85°C					
Maximum Junction Temperature (T _J max)	150°C					
Storage Temperature Range	−65°C to +150°C					
Lead Temperature, Soldering						
Vapor Phase (60 sec)	215°C					
Infrared (15 sec)	220°C					
Thermal Resistance						
Junction-to-Ambient θ _{JA} ,TSSOP-16	150°C/W					
Junction-to-Case θ_{JC} , TSSOP-16	28°C/W					
Package Power Dissipation	$(T_J max - T_A)/\theta_{JA}$					
· · · · · · · · · · · · · · · · · · ·						

¹ Maximum terminal current is bounded by the maximum current handling of the switches, maximum power dissipation of the package, and maximum applied voltage across any two of the A, B, and W terminals at a given resistance.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

² Includes programming of nonvolatile memory.

PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

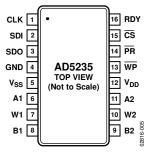


Figure 4. Pin Configuration

Table 4. Pin Function Descriptions

Pin No.	Mnemonic	Description
1	CLK	Serial Input Register Clock. Shifts in one bit at a time on positive clock edges.
2	SDI	Serial Data Input. Shifts in one bit at a time on positive clock CLK edges. MSB loads first.
3	SDO	Serial Data Output. Serves readback and daisy-chain functions. Command 9 and Command 10 activate the SDO output for the readback function, delayed by 24 or 25 clock pulses, depending on the clock polarity before and after the data-word (see Figure 2 and Figure 3). In other commands, the SDO shifts out the previously loaded SDI bit pattern, delayed by 24 or 25 clock pulses depending on the clock polarity (see Figure 2 and Figure 3). This previously shifted out SDI can be used for daisy-chaining multiple devices. Whenever SDO is used, a pull-up resistor in the range of 1 k Ω to 10 k Ω is needed.
4	GND	Ground Pin, Logic Ground Reference.
5	V _{SS}	Negative Supply. Connect to 0 V for single-supply applications. If V _{SS} is used in dual supply, it must be able to sink 2 mA for 15 ms when storing data to EEMEM.
6	A1	Terminal A of RDAC1.
7	W1	Wiper terminal of RDAC1. ADDR (RDAC1) = $0x0$.
8	B1	Terminal B of RDAC1.
9	B2	Terminal B of RDAC2.
10	W2	Wiper terminal of RDAC2. ADDR (RDAC2) = $0x1$.
11	A2	Terminal A of RDAC2.
12	V _{DD}	Positive Power Supply.
13	WP	Optional Write Protect. When active low, \overline{WP} prevents any changes to the present contents, except \overline{PR} strobe. CMD_1 and COMD_8 refresh the RDAC register from EEMEM. Tie \overline{WP} to V_{DD} , if not used.
14	PR	Optional Hardware Override Preset. Refreshes the scratchpad register with current contents of the EEMEM register. Factory default loads midscale until EEMEM is loaded with a new value by the user. PR is activated at the logic high transition. Tie PR to V _{DD} , if not used.
15	CS	Serial Register Chip Select Active Low. Serial register operation takes place when CS returns to logic high.
16	RDY	Ready. Active high open-drain output. Identifies completion of Instruction 2, Instruction 3, Instruction 8, Instruction 9, Instruction 10, and PR.

TYPICAL PERFORMANCE CHARACTERISTICS

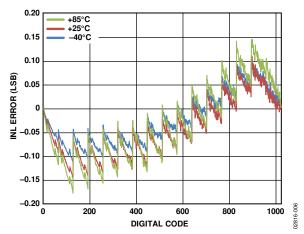


Figure 5. INL vs. Code, $T_A = -40$ °C, +25°C, +85°C Overlay, $R_{AB} = 25$ k Ω

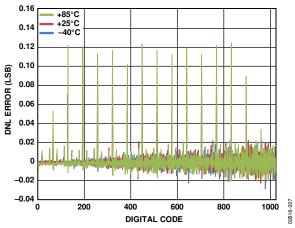


Figure 6. DNL vs. Code, $T_A = -40$ °C, +25°C, +85°C Overlay, $R_{AB} = 25$ k Ω

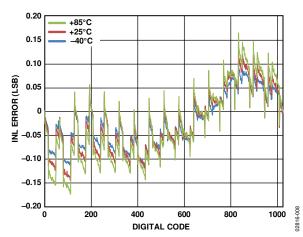


Figure 7. R-INL vs. Code, $T_A = -40$ °C, +25°C, +85°C Overlay, $R_{AB} = 25$ k Ω

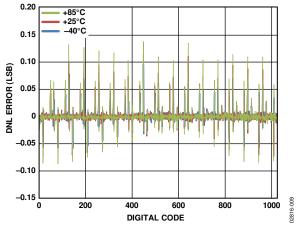


Figure 8. R-DNL vs. Code, $T_A = -40$ °C, +25°C, +85°C Overlay, $R_{AB} = 25$ k Ω

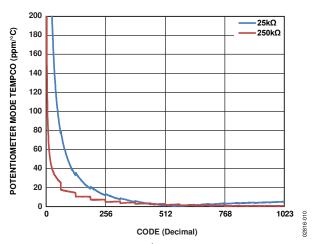


Figure 9. $(\Delta V_W/V_W)/\Delta T \times 10^6$ Potentiometer Mode Tempco

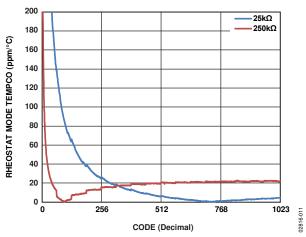


Figure 10. ($\Delta R_{WB}/R_{WB}$)/ $\Delta T \times 10^6$ Rheostat Mode Tempco

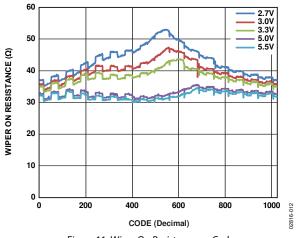


Figure 11. Wiper On Resistance vs. Code

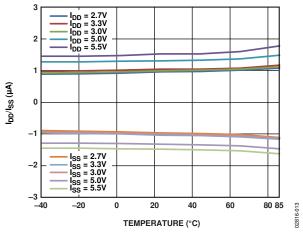


Figure 12. IDD vs. Temperature

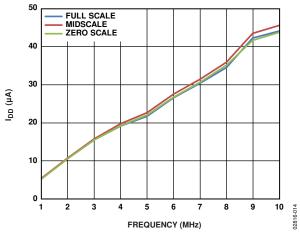


Figure 13. I_{DD} vs. Clock Frequency, $R_{AB} = 25 \text{ k}\Omega$

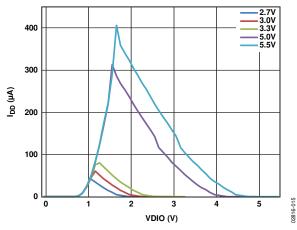


Figure 14. IDD vs. Digital Input Voltage

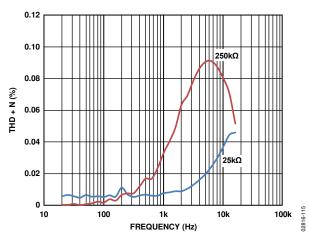


Figure 15. THD + Noise vs. Frequency

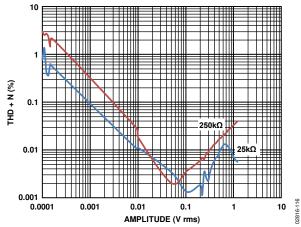


Figure 16. THD + Noise vs. Amplitude

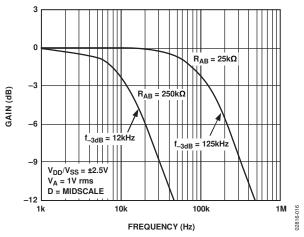


Figure 17. –3 dB Bandwidth vs. Resistance (See Figure 33)

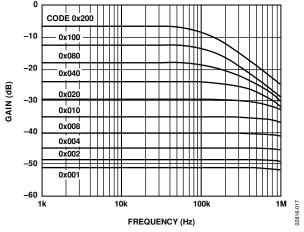


Figure 18. Gain vs. Frequency vs. Code, $R_{AB} = 25 \text{ k}\Omega$ (See Figure 33)

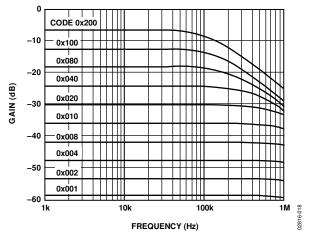


Figure 19. Gain vs. Frequency vs. Code, $R_{AB} = 250 \text{ k}\Omega$ (See Figure 33)

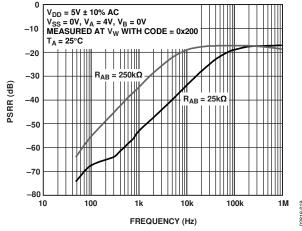


Figure 20. PSRR vs. Frequency

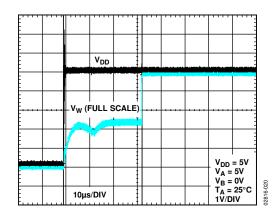


Figure 21. Power-On Reset

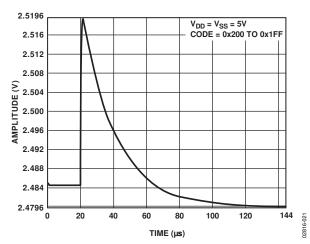


Figure 22. Midscale Glitch Energy, $R_{AB} = 25 \text{ k}\Omega$

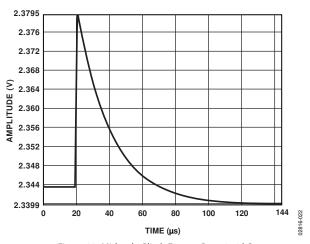


Figure 23. Midscale Glitch Energy, $R_{AB} = 250 \text{ k}\Omega$

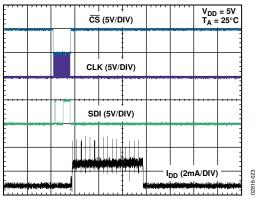


Figure 24. I_{DD} vs. Time when Storing Data to EEMEM

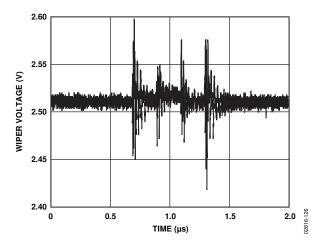


Figure 25. Digital Feedthrough

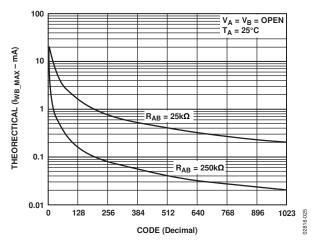


Figure 26. I_{WB_MAX} vs. Code

TEST CIRCUITS

Figure 27 to Figure 37 define the test conditions used in the Specifications section.

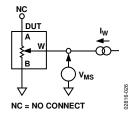


Figure 27. Resistor Position Nonlinearity Error (Rheostat Operation; R-INL, R-DNL)

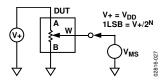


Figure 28. Potentiometer Divider Nonlinearity Error (INL, DNL)

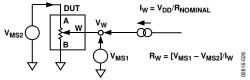


Figure 29. Wiper Resistance

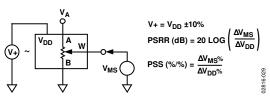


Figure 30. Power Supply Sensitivity (PSS, PSRR)

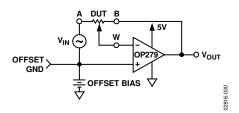


Figure 31. Inverting Gain

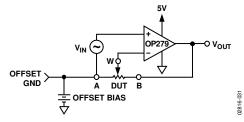


Figure 32. Noninverting Gain

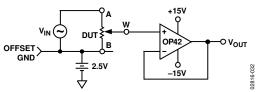


Figure 33. Gain vs. Frequency

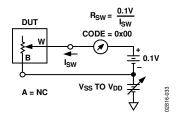


Figure 34. Incremental On Resistance

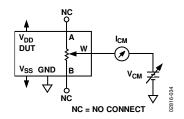


Figure 35. Common-Mode Leakage Current

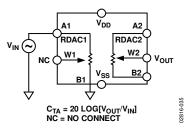


Figure 36. Analog Crosstalk

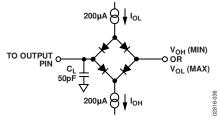


Figure 37. Load Circuit for Measuring V_{OH} and V_{OL} (The diode bridge test circuit is equivalent to the application circuit with $R_{PULL-UP}$ of 2.2 k Ω .)

THEORY OF OPERATION

The AD5235 digital potentiometer is designed to operate as a true variable resistor. The resistor wiper position is determined by the RDAC register contents. The RDAC register acts as a scratchpad register, allowing unlimited changes of resistance settings. The scratchpad register can be programmed with any position setting using the standard SPI serial interface by loading the 24-bit data-word. In the format of the data-word, the first four bits are commands, the following four bits are addresses, and the last 16 bits are data. When a specified value is set, this value can be stored in a corresponding EEMEM register. During subsequent power-ups, the wiper setting is automatically loaded to that value.

Storing data to the EEMEM register takes about 15 ms and consumes approximately 2 mA. During this time, the shift register is locked, preventing any changes from taking place. The RDY pin pulses low to indicate the completion of this EEMEM storage. There are also 13 addresses with two bytes each of user-defined data that can be stored in the EEMEM register from Address 2 to Address 14.

The following instructions facilitate the programming needs of the user (see Table 7 for details):

- 0. Do nothing.
- 1. Restore EEMEM content to RDAC.
- Store RDAC setting to EEMEM.
- 3. Store RDAC setting or user data to EEMEM.
- 4. Decrement by 6 dB.
- 5. Decrement all by 6 dB.
- 6. Decrement by one step.
- 7. Decrement all by one step.
- 8. Reset EEMEM content to RDAC.
- 9. Read EEMEM content from SDO.
- 10. Read RDAC wiper setting from SDO.
- 11. Write data to RDAC.
- 12. Increment by 6 dB.
- 13. Increment all by 6 dB.
- 14. Increment by one step.
- 15. Increment all by one step.

Table 14 to Table 20 provide programming examples that use some of these commands.

SCRATCHPAD AND EEMEM PROGRAMMING

The scratchpad RDAC register directly controls the position of the digital potentiometer wiper. For example, when the scratchpad register is loaded with all 0s, the wiper is connected to Terminal B of the variable resistor. The scratchpad register is a standard logic register with no restriction on the number of changes allowed, but the EEMEM registers have a program erase/write cycle limitation.

BASIC OPERATION

The basic mode of setting the variable resistor wiper position (programming the scratchpad register) is accomplished by loading the serial data input register with Instruction 11 (0xB), Address 0, and the desired wiper position data. When the proper wiper position is determined, the user can load the serial data input register with Instruction 2 (0x2), which stores the wiper position data in the EEMEM register. After 15 ms, the wiper position is permanently stored in nonvolatile memory.

Table 5 provides a programming example listing the sequence of the serial data input (SDI) words with the serial data output appearing at the SDO pin in hexadecimal format.

Table 5. Write and Store RDAC Settings to EEMEM Registers

SDI	SDO	Action
0xB00100	0xXXXXXX	Writes data 0x100 to the RDAC1 register, Wiper W1 moves to 1/4 full-scale position.
0x20XXXX	0xB00100	Stores RDAC1 register content into the EEMEM1 register.
0xB10200	0x20XXXX	Writes Data 0x200 to the RDAC2 register, Wiper W2 moves to 1/2 full-scale position.
0x21XXXX	0xB10200	Stores RDAC2 register contents into the EEMEM2 register.

At system power-on, the scratchpad register is automatically refreshed with the value previously stored in the corresponding EEMEM register. The factory-preset EEMEM value is midscale. The scratchpad register can also be refreshed with the contents of the EEMEM register in three different ways. First, executing Instruction 1 (0x1) restores the corresponding EEMEM value. Second, executing Instruction 8 (0x8) resets the EEMEM values of both channels. Finally, pulsing the \overline{PR} pin refreshes both EEMEM settings. Operating the hardware control \overline{PR} function requires a complete pulse signal. When \overline{PR} goes low, the internal logic sets the wiper at midscale. The EEMEM value is not loaded until \overline{PR} returns high.

EEMEM PROTECTION

The write protect (\overline{WP}) pin disables any changes to the scratchpad register contents, except for the EEMEM setting, which can still be restored using Instruction 1, Instruction 8, and the \overline{PR} pulse. Therefore, \overline{WP} can be used to provide a hardware EEMEM protection feature.

DIGITAL INPUT AND OUTPUT CONFIGURATION

All digital inputs are ESD protected, high input impedance that can be driven directly from most digital sources. Active at logic low, \overline{PR} and \overline{WP} must be tied to V_{DD} , if they are not used. No internal pull-up resistors are present on any digital input pins. To avoid floating digital pins that might cause false triggering in a noisy environment, add pull-up resistors. This is applicable when the device is detached from the driving source when it is programmed.

The SDO and RDY pins are open-drain digital outputs that only need pull-up resistors if these functions are used. To optimize the speed and power trade-off, use $2.2 \text{ k}\Omega$ pull-up resistors.

The equivalent serial data input and output logic is shown in Figure 38. The open-drain output SDO is disabled whenever chip-select (\overline{CS}) is in logic high. ESD protection of the digital inputs is shown in Figure 39 and Figure 40.

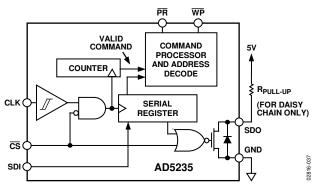


Figure 38. Equivalent Digital Input and Output Logic

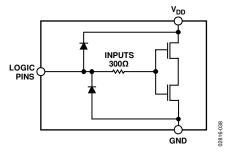


Figure 39. Equivalent ESD Digital Input Protection

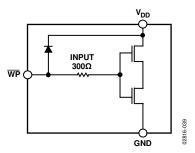


Figure 40. Equivalent WP Input Protection

SERIAL DATA INTERFACE

The AD5235 contains a 4-wire SPI-compatible digital interface (SDI, SDO, \overline{CS} , and CLK). The 24-bit serial data-word must be loaded with MSB first. The format of the word is shown in Table 6. The command bits (C0 to C3) control the operation of the digital potentiometer according to the command shown in Table 7. A0 to A3 are the address bits. A0 is used to address RDAC1 or RDAC2. Address 2 to Address 14 are accessible by users for extra EEMEM. Address 15 is reserved for factory usage. Table 9 provides an address map of the EEMEM locations. D0 to D9 are the values for the RDAC registers. D0 to D15 are the values for the EEMEM registers.

The AD5235 has an internal counter that counts a multiple of 24 bits (a frame) for proper operation. For example, AD5235 works with a 24-bit or 48-bit word, but it cannot work properly with a 23-bit or 25-bit word. To prevent data from mislocking (due to noise, for example), the counter resets, if the count is not a multiple of four when $\overline{\text{CS}}$ goes high but remains in the register if it is multiple of four. In addition, the AD5235 has a subtle feature that, if $\overline{\text{CS}}$ is pulsed without CLK and SDI, the part repeats the previous command (except during power-up). As a result, care must be taken to ensure that no excessive noise exists in the CLK or $\overline{\text{CS}}$ line that might alter the effective number-of-bits pattern.

The SPI interface can be used in two slave modes: CPHA = 1, CPOL = 1 and CPHA = 0, CPOL = 0. CPHA and CPOL refer to the control bits that dictate SPI timing in the following MicroConverters* and microprocessors: ADuC812, ADuC824, M68HC11, MC68HC16R1, and MC68HC916R1.

DAISY-CHAIN OPERATION

The serial data output pin (SDO) serves two purposes. It can be used to read the contents of the wiper setting and EEMEM values using Instruction 10 and Instruction 9, respectively. The remaining instructions (Instruction 0 to Instruction 8, Instruction 11 to Instruction 15) are valid for daisy-chaining multiple devices in simultaneous operations. Daisy-chaining minimizes the number of port pins required from the controlling IC (see Figure 41). The SDO pin contains an open-drain N-Ch FET that requires a pull-up resistor, if this function is used. As shown in Figure 41, users need to tie the SDO pin of one package to the SDI pin of the next package. Users may need to increase the clock period because the pull-up resistor and the capacitive loading at the SDO-to-SDI interface may require additional time delay between subsequent devices.

When two AD5235s are daisy-chained, 48 bits of data are required. The first 24 bits (formatted 4-bit command, 4-bit address, and 16-bit data) go to U2, and the second 24 bits with the same format go to U1. Keep $\overline{\text{CS}}$ low until all 48 bits are clocked into their respective serial registers. $\overline{\text{CS}}$ is then pulled high to complete the operation.

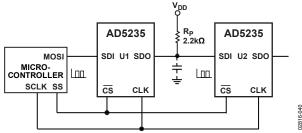


Figure 41. Daisy-Chain Configuration Using SDO

TERMINAL VOLTAGE OPERATING RANGE

The positive $V_{\rm DD}$ and negative $V_{\rm SS}$ power supplies of the AD5235 define the boundary conditions for proper 3-terminal digital potentiometer operation. Supply signals present on Terminal A, Terminal B, and Terminal W that exceed $V_{\rm DD}$ or $V_{\rm SS}$ are clamped by the internal forward-biased diodes (see Figure 42).

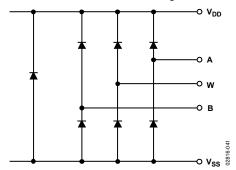


Figure 42. Maximum Terminal Voltages Set by V_{DD} and V_{SS}

The GND pin of the AD5235 is primarily used as a digital ground reference. To minimize the digital ground bounce, the AD5235 ground terminal should be joined remotely to the common ground (see Figure 43). The digital input control signals to the AD5235 must be referenced to the device ground pin (GND) and must satisfy the logic level defined in the Specifications section. An internal level-shift circuit ensures that the common-mode voltage range of the three terminals extends from V_{SS} to V_{DD} , regardless of the digital input level.

Power-Up Sequence

Because there are diodes to limit the voltage compliance at Terminal A, Terminal B, and Terminal W (see Figure 42), it is important to power $V_{\rm DD}$ and $V_{\rm SS}$ first before applying any voltage to Terminal A, Terminal B, and Terminal W. Otherwise, the diode is forward-biased such that $V_{\rm DD}$ and $V_{\rm SS}$ are powered unintentionally. For example, applying 5 V across Terminal A and Terminal B prior to $V_{\rm DD}$ causes the $V_{\rm DD}$ terminal to exhibit 4.3 V. It is not destructive to the device, but it might affect the rest of the user's system. The ideal power-up sequence is GND, $V_{\rm DD}$ and $V_{\rm SS}$, digital inputs, and $V_{\rm A}$, $V_{\rm B}$, and $V_{\rm W}$. The order of powering $V_{\rm A}$, $V_{\rm B}$, $V_{\rm W}$, and the digital inputs is not important as long as they are powered after $V_{\rm DD}$ and $V_{\rm SS}$.

Regardless of the power-up sequence and the ramp rates of the power supplies, when $V_{\rm DD}$ and $V_{\rm SS}$ are powered, the power-on preset activates, which restores the EEMEM values to the RDAC registers.

Layout and Power Supply Bypassing

It is a good practice to employ compact, minimum lead-length layout design. The leads to the input should be as direct as possible with a minimum conductor length. Ground paths should have low resistance and low inductance.

Similarly, it is good practice to bypass the power supplies with quality capacitors for optimum stability. Bypass supply leads to the device with 0.01 μF to 0.1 μF disk or chip ceramic capacitors. Also, apply low ESR, 1 μF to 10 μF tantalum or electrolytic capacitors at the supplies to minimize any transient disturbance (see Figure 43).

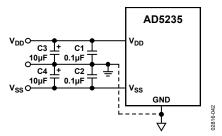


Figure 43. Power Supply Bypassing

In Table 6, command bits are C0 to C3, address bits are A0 to A3, Data Bit D0 to Data Bit D9 are applicable to RDAC, and D0 to D15 are applicable to EEMEM.

Table 6. 24-Bit Serial Data-Word

	MSE	3		Co	mmar	nd Byt	e 0			Data Byte 1							Data Byte 0								
RDAC	C3	C2	C1	C0	0	0	0	A0	Χ	Χ	Χ	Χ	Χ	Χ	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	
EEMEM	C3	C2	C1	C0	A3	A2	A1	A0	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	

Command instruction codes are defined in Table 7.

Table 7. Command Operation Truth Table 1, 2, 3

1 4010 7. 0					nd Byt				ı	Data I	Byte 1		Data Byte 0			
Command	B23							B16	B15			B8	B7		В0	
Number	C3	C2	C1	C0	А3	A2	A 1	A0	X	•••	D9	D8	D7	•••	D0	Operation
0	0	0	0	0	Χ	Χ	Χ	Χ	Χ		Χ	Χ	Χ	•••	Χ	NOP. Do nothing. See Table 19
1	0	0	0	1	0	0	0	A0	Х	•••	Χ	Χ	Х	•••	Χ	Restore EEMEM (A0) contents to RDAC (A0) register. See Table 16.
2	0	0	1	0	0	0	0	A0	Х	•••	Χ	Χ	Х	•••	Χ	Store wiper setting. Store RDAC (A0) setting to EEMEM (A0). See Table 15.
3 ⁴	0	0	1	1	А3	A2	A1	A0	D15			D8	D7	•••	D0	Store contents of Serial Register Data Byte 0 and Serial Register Data Bytes 1 (total 16 bits) to EEMEM (ADDR). See Table 18.
4 ⁵	0	1	0	0	0	0	0	A0	Х	•••	Χ	Х	Х	•••	Х	Decrement by 6 dB. Right-shift contents of RDAC (A0) register, stop at all 0s.
5 ⁵	0	1	0	1	Х	Χ	Χ	Χ	Х	•••	Χ	Х	Х	•••	Х	Decrement all by 6 dB. Right-shift contents of all RDAC registers, stop at all 0s.
6 ⁵	0	1	1	0	0	0	0	A0	Х	•••	Χ	Х	Х	•••	Х	Decrement contents of RDAC (A0) by 1, stop at all 0s.
7 ⁵	0	1	1	1	Х	Χ	Х	Χ	Х	•••	Χ	Х	Х	•••	Х	Decrement contents of all RDAC registers by 1, stop at all 0s.
8	1	0	0	0	0	0	0	0	Х	•••	Х	Х	Х	•••	Х	Reset. Refresh all RDACs with their corresponding EEMEM previously stored values.
9	1	0	0	1	А3	A2	A1	A0	Х	•••	Χ	Х	Х	•••	Х	Read contents of EEMEM (ADDR) from SDO output in the next frame. See Table 19.
10	1	0	1	0	0	0	0	A0	Х		Х	Х	Х		Χ	Read RDAC wiper setting from SDO output in the next frame. See Table 20.
11	1	0	1	1	0	0	0	A0	Х		D9	D8	D7		D0	Write contents of Serial Register Data Byte 0 and Serial Register Data Byte 1 (total 10 bits) to RDAC (A0). See Table 14.
125	1	1	0	0	0	0	0	A0	Х		Χ	Χ	Х		Χ	Increment by 6 dB: Left-shift contents of RDAC (A0), stop at all 1s. See Table 17.
13 ⁵	1	1	0	1	Х	Χ	Χ	Χ	Х	•••	Χ	Χ	Х	•••	Х	Increment all by 6 dB. Left-shift contents of all RDAC registers, stop at all 1s.
14 ⁵	1	1	1	0	0	0	0	A0	Х		Χ	Χ	Х		Χ	Increment contents of RDAC (A0) by 1, stop at all 1s. See Table 15.
15 ⁵	1	1	1	1	Х	Х	Х	Х	Х		Х	Х	Х	•••	Х	Increment contents of all RDAC registers by 1, stop at all 1s.

¹ The SDO output shifts out the last 24 bits of data clocked into the serial register for daisy-chain operation. Exception: for any instruction following Instruction 9 or Instruction 10, the selected internal register data is present in Data Byte 0 and Data Byte 1. The instructions following Instruction 9 and Instruction 10 must also be a full 24-bit data-word to completely clock out the contents of the serial register.

² The RDAC register is a volatile scratchpad register that is refreshed at power-on from the corresponding nonvolatile EEMEM register.

 $^{^3}$ Execution of these operations takes place when the $\overline{\text{CS}}$ strobe returns to logic high.

⁴ Instruction 3 writes two data bytes (16 bits of data) to EEMEM. In the case of Address 0 and Address 1, only the last 10 bits are valid for wiper position setting.

⁵ The increment, decrement, and shift instructions ignore the contents of the shift register, Data Byte 0 and Data Byte 1.

ADVANCED CONTROL MODES

The AD5235 digital potentiometer includes a set of user programming features to address the wide number of applications for these universal adjustment devices.

Key programming features include the following:

- Scratchpad programming to any desirable values
- Nonvolatile memory storage of the scratchpad RDAC register value in the EEMEM register
- Increment and decrement instructions for the RDAC wiper register
- Left and right bit shift of the RDAC wiper register to achieve ±6 dB level changes
- 26 extra bytes of user-addressable nonvolatile memory

Linear Increment and Decrement Instructions

The increment and decrement instructions (Instruction 14, Instruction 15, Instruction 6, and Instruction 7) are useful for linear step adjustment applications. These commands simplify microcontroller software coding by allowing the controller to send just an increment or decrement command to the device. The adjustment can be individual or in a ganged potentiometer arrangement where both wiper positions are changed at the same time.

For an increment command, executing Instruction 14 automatically moves the wiper to the next resistance segment position. The master increment command, Instruction 15, moves all resistor wipers up by one position.

Logarithmic Taper Mode Adjustment

Four programming instructions produce logarithmic taper increment and decrement of the wiper position control by an individual potentiometer or by a ganged potentiometer arrangement where both wiper positions are changed at the same time. The 6 dB increment is activated by Instruction 12 and Instruction 13, and the 6 dB decrement is activated by Instruction 4 and Instruction 5. For example, starting with the wiper connected to Terminal B, executing 11 increment instructions (Command Instruction 12) moves the wiper in 6 dB steps from 0% of the $R_{\rm AB}$ (Terminal B) position to 100% of the $R_{\rm AB}$ position of the AD5235 10-bit potentiometer. When the wiper position is near the maximum setting, the last 6 dB increment instruction causes the wiper to go to the full-scale 1023 code position. Further 6 dB per increment instructions do not change the wiper position beyond its full scale (see Table 8).

The 6 dB step increments and 6 dB step decrements are achieved by shifting the bit internally to the left or right, respectively. The following information explains the nonideal ± 6 dB step adjustment under certain conditions. Table 8 illustrates the operation of the shifting function on the RDAC register data bits. Each table row represents a successive shift operation. Note that the left-shift 12 and 13 instructions were modified such that, if the data in the RDAC register is equal to zero and the data is shifted left,

the RDAC register is then set to Code 1. Similarly, if the data in the RDAC register is greater than or equal to midscale and the data is shifted left, then the data in the RDAC register is automatically set to full scale. This makes the left-shift function as ideal a logarithmic adjustment as possible.

The Right-Shift 4 instruction and Right-Shift 5 instruction are ideal only if the LSB is 0 (ideal logarithmic = no error). If the LSB is 1, the right-shift function generates a linear half-LSB error, which translates to a number-of-bits dependent logarithmic error, as shown in Figure 44. Figure 44 shows the error of the odd numbers of bits for the AD5235.

Table 8. Detail Left-Shift and Right-Shift Functions for 6 dB Step Increment and Decrement

Left-Shift (+6 dB/Step)	Right-Shift(-6 dB/Step)
00 0000 0000	11 1111 1111
00 0000 0001	01 1111 1111
00 0000 0010	00 1111 1111
00 0000 0100	00 0111 1111
00 0000 1000	00 0011 1111
00 0001 0000	00 0001 1111
00 0010 0000	00 0000 1111
00 0100 0000	00 0000 0111
00 1000 0000	00 0000 0011
01 0000 0000	00 0000 0001
10 0000 0000	00 0000 0000
11 1111 1111	00 0000 0000
11 1111 1111	00 0000 0000

Actual conformance to a logarithmic curve between the data contents in the RDAC register and the wiper position for each Right-Shift 4 command and Right-Shift 5 command execution contains an error only for odd numbers of bits. Even numbers of bits are ideal. Figure 44 shows plots of log error [$20 \times log_{10}$ (error/code)] for the AD5235. For example, Code 3 log error = $20 \times log_{10}$ (0.5/3) = -15.56 dB, which is the worst case. The log error plot is more significant at the lower codes (see Figure 44).

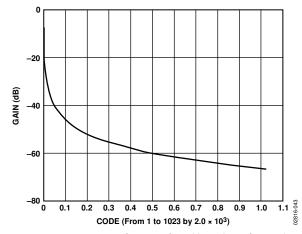


Figure 44. Log Error Conformance for Odd Numbers of Bits Only (Even Numbers of Bits Are Ideal)

Using CS to Re-Execute a Previous Command

Another subtle feature of the AD5235 is that a subsequent $\overline{\text{CS}}$ strobe, without clock and data, repeats a previous command.

Using Additional Internal Nonvolatile EEMEM

The AD5235 contains additional user EEMEM registers for storing any 16-bit data such as memory data for other components, look-up tables, or system identification information. Table 9 provides an address map of the internal storage registers shown in the functional block diagram (see Figure 1) as EEMEM1, EEMEM2, and 26 bytes (13 addresses × 2 bytes each) of User EEMEM.

Table 9. EEMEM Address Map

EEMEM No.	Address	EEMEM Content for
1	0000	RDAC1 ¹
2	0001	RDAC2
3	0010	USER1 ²
4	0011	USER2
•••		
15	1110	USER13
16	1111	R _{AB1} tolerance ³

¹ RDAC data stored in EEMEM locations is transferred to the corresponding RDAC register at power-on, or when Instruction 1, Instruction 8, and PR are executed.

Calculating Actual End-to-End Terminal Resistance

The resistance tolerance is stored in the EEMEM register during factory testing. The actual end-to-end resistance can, therefore, be calculated, which is valuable for calibration, tolerance matching, and precision applications. Note that this value is read only and the R_{AB2} matches with R_{AB1} , typically 0.1%.

The resistance tolerance in percentage is contained in the last 16 bits of data in EEMEM Register 15. The format is the sign magnitude binary format with the MSB designate for sign (0 = negative and 1 = positive), the next 7 MSB designate the integer number, and the 8 LSB designate the decimal number (see Table 11).

For example, if R_{AB_RATED} = 250 k Ω and the data in the SDO shows XXXX XXXX 1001 1100 0000 1111, R_{AB_ACTUAL} can be calculated as follows:

MSB: 1 = positive Next 7 LSB: 001 1100 = 28 8 LSB: 0000 1111 = 15 \times 2⁻⁸ = 0.06 % tolerance = 28.06% Therefore, R_{AB_ACTUAL} = 320.15 k Ω

RDAC STRUCTURE

The patent-pending RDAC contains multiple strings of equal resistor segments with an array of analog switches that acts as the wiper connection. The number of positions is the resolution of the device. The AD5235 has 1024 connection points, allowing it to provide better than 0.1% setability resolution. Figure 45 shows an equivalent structure of the connections among the three terminals of the RDAC. The SW_A and SW_B are always on, while the switches, SW(0) to SW(2^N – 1), are on one at a time, depending on the resistance position decoded from the data bits. Because the switch is not ideal, there is a 50 Ω wiper resistance, $R_{\rm W}$. Wiper resistance is a function of supply voltage and temperature. The lower the supply voltage or the higher the temperature, the higher the resulting wiper resistance. Users should be aware of the wiper resistance dynamics, if accurate prediction of the output resistance is needed.

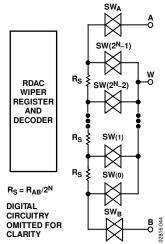


Figure 45. Equivalent RDAC Structure

Table 10. Nominal Individual Segment Resistor Values

Device Resolution	25 kΩ	250 kΩ
1024-Step	24.4	244

Table 11. Calculating End-to-End Terminal Resistance

Bit	D15	D14	D13	D12	D11	D10	D9	D8
Sign								
Mag	Sign	2 ⁶	2 ⁵	2 ⁴	2 ³	2 ²	2 ¹	2 ⁰

7 Bits for Integer Number

Decimal Point

D7	D6	D5	D4	D3	D2	D1	D0
2 ⁻¹	2-2	2-3	2-4	2 ⁻⁵	2 ⁻⁶	2 ⁻⁷	2-8

8 Bits for Decimal Number

² USERx are internal nonvolatile EEMEM registers available to store and retrieve constants and other 16-bit information using Instruction 3 and Instruction 9, respectively.

³ Read only.

PROGRAMMING THE VARIABLE RESISTOR

Rheostat Operation

The nominal resistance of the RDAC between Terminal A and Terminal B, R_{AB} , is available with 25 k Ω and 250 k Ω with 1024 positions (10-bit resolution). The final digits of the part number determine the nominal resistance value, for example, 25 k Ω = 24.4 Ω : 250 k Ω = 244 Ω .

The 10-bit data-word in the RDAC latch is decoded to select one of the 1024 possible settings. The following description provides the calculation of resistance, R_{WB} , at different codes of a 25 k Ω part. The first connection of the wiper starts at Terminal B for Data 0x000. $R_{WB}(0)$ is 30 Ω because of the wiper resistance, and it is independent of the nominal resistance. The second connection is the first tap point where $R_{WB}(1)$ becomes 24.4 Ω + 30 Ω = 54.4 Ω for Data 0x001. The third connection is the next tap point representing $R_{WB}(2)$ = 48.8 Ω + 30 Ω = 78.8 Ω for Data 0x002, and so on. Each LSB data value increase moves the wiper up the resistor ladder until the last tap point is reached at $R_{WB}(1023)$ = 25006 Ω . See Figure 45 for a simplified diagram of the equivalent RDAC circuit. When R_{WB} is used, Terminal A can be left floating or tied to the wiper.

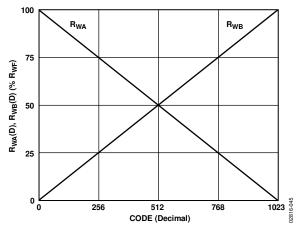


Figure 46. R_{WA}(D) and R_{WB}(D) vs. Decimal Code

The general equation that determines the programmed output resistance between Terminal Bx and Terminal Wx is

$$R_{WB}(D) = \frac{D}{1024} \times R_{AB} + R_W \tag{1}$$

where:

 ${\cal D}$ is the decimal equivalent of the data contained in the RDAC register.

 R_{AB} is the nominal resistance between Terminal A and Terminal B. R_W is the wiper resistance.

For example, the output resistance values in Table 12 are set for the given RDAC latch codes (applies to R_{AB} = 25 $k\Omega$ digital potentiometers).

Table 12. R_{WB} (D) at Selected Codes for $R_{AB} = 25 \text{ k}\Omega$

D (Dec)	$R_{WB}(D)(\Omega)$	Output State
1023	25,006	Full scale
512	12,530	Midscale
1	54.4	1 LSB
0	30	Zero scale (wiper contact resistor)

Note that, in the zero-scale condition, a finite wiper resistance of 50 Ω is present. Care should be taken to limit the current flow between W and B in this state to no more than 20 mA to avoid degradation or possible destruction of the internal switches.

Like the mechanical potentiometer that the RDAC replaces, the AD5235 part is symmetrical. The resistance between Wiper W and Terminal A also produces a digitally controlled complementary resistance, R_{WA} . Figure 46 shows the symmetrical programmability of the various terminal connections. When R_{WA} is used, Terminal B can be left floating or tied to the wiper. Setting the resistance value for R_{WA} starts at a maximum value of resistance and decreases as the data loaded in the latch is increased in value.

The general transfer equation for this operation is

$$R_{WA}(D) = \frac{1024 - D}{1024} \times R_{AB} + R_{W}$$
 (2)

For example, the output resistance values in Table 13 are set for the given RDAC latch codes (applies to R_{AB} = 25 $k\Omega$ digital potentiometers).

Table 13. $R_{WA}(D)$ at Selected Codes for $R_{AB} = 25 \text{ k}\Omega$

D (Dec)	$R_{WA}(D)(\Omega)$	Output State
1023	54.4	Full scale
512	12,530	Midscale
1	25,006	1 LSB
0	25,030	Zero scale (wiper contact resistance)

The typical distribution of R_{AB} from channel to channel is $\pm 0.2\%$ within the same package. Device-to-device matching is process lot dependent upon the worst case of $\pm 30\%$ variation. However, the change in R_{AB} with temperature has a 35 ppm/°C temperature coefficient.

PROGRAMMING THE POTENTIOMETER DIVIDER Voltage Output Operation

The digital potentiometer can be configured to generate an output voltage at the wiper terminal that is proportional to the input voltages applied to Terminal A and Terminal B. For example, connecting Terminal A to 5 V and Terminal B to ground produces an output voltage at the wiper that can be any value from 0 V to 5 V. Each LSB of voltage is equal to the voltage applied across Terminal A to Terminal B divided by the $2^{\rm N}$ position resolution of the potentiometer divider.

Because the AD5235 can also be supplied by dual supplies, the general equation defining the output voltage at $V_{\rm W}$ with respect to ground for any given input voltages applied to Terminal A and Terminal B is

$$V_W(D) = \frac{D}{1024} \times V_{AB} + V_B$$
 (3)

Equation 3 assumes that V_W is buffered so that the effect of wiper resistance is minimized. Operation of the digital potentiometer in divider mode results in more accurate operation over temperature. Here, the output voltage is dependent on the ratio of the internal resistors and not the absolute value; therefore, the drift improves to 15 ppm/°C. There is no voltage polarity restriction between Terminal A, Terminal B, and Terminal W as long as the terminal voltage (V_{TERM}) stays within $V_{\text{SS}} < V_{\text{TERM}} < V_{\text{DD}}$.

PROGRAMMING EXAMPLES

The following programming examples illustrate a typical sequence of events for various features of the AD5235. See Table 7 for the instructions and data-word format. The instruction numbers, addresses, and data appearing at the SDI and SDO pins are in hexadecimal format.

Table 14. Scratchpad Programming

SDI	SDO	Action
0xB00100	0xXXXXXX	Writes Data 0x100 into RDAC1 register, Wiper W1 moves to 1/4 full-scale position.
0xB10200	0xB00100	Loads Data 0x200 into RDAC2 register, Wiper W2 moves to 1/2 full-scale position.

Table 15. Incrementing RDAC Followed by Storing the Wiper Setting to EEMEM

,, 15 or occurs to 222, 222, 2			
SDI	SDO	Action	
0xB00100	0xXXXXXX	Writes Data 0x100 into RDAC1 register, Wiper W1 moves to 1/4 full-scale position.	
0xE0XXXX	0xB00100	Increments RDAC1 register by one to 0x101.	
0xE0XXXX	0xE0XXXX	Increments RDAC1 register by one to 0x102. Continue until desired wiper position is reached.	
0x20XXXX	0xXXXXXX	Stores RDAC2 register data into EEMEM1. Optionally, tie WP to GND to protect EEMEM values.	

The EEMEM values for the RDACs can be restored by poweron, by strobing the \overline{PR} pin, or by the two commands shown in Table 16.

Table 16. Restoring the EEMEM Values to RDAC Registers

SDI	SDO	Action
0x10XXXX	0xXXXXXX	Restores the EEMEM1 value to the RDAC1 register.

Table 17. Using Left-Shift by One to Increment 6 dB Steps

SDI	SDO	Action
0xC0XXXX	0xXXXXXX	Moves Wiper 1 to double the present data contained in the RDAC1 register.
0xC1XXXX	0xC0XXXX	Moves Wiper 2 to double the present data contained in the RDAC2 register.

Table 18. Storing Additional User Data in EEMEM

SDI	SDO	Action
0x32AAAA	0xXXXXXX	Stores Data 0xAAAA in the extra EEMEM location USER1. (Allowable to address in 13 locations with a maximum of 16 bits of data.)
0x335555	0x32AAAA	Stores Data 0x5555 in the extra EEMEM location USER2. (Allowable to address in 13 locations with a maximum of 16 bits of data.)

Table 19. Reading Back Data from Memory Locations

SDI	SDO	Action
0x92XXXX	0xXXXXXX	Prepares data read from USER1 EEMEM location.
0x00XXXX	0x92AAAA	NOP Instruction 0 sends a 24-bit word out of SDO, where the last 16 bits contain the contents in USER1 EEMEM location.

Table 20. Reading Back Wiper Settings

	Action
0xXXXXXX	Writes RDAC1 to midscale.
0xB00200	Doubles RDAC1 from midscale to full scale.
0xC0XXXX	Prepares reading wiper setting from RDAC1 register.
0xA003FF	Reads back full-scale value from SDO.
c	0xB00200

EVAL-AD5235SDZ EVALUATION KIT

Analog Devices, Inc., offers a user-friendly EVAL-AD5235SDZ evaluation kit that can be controlled by a PC in conjunction with the SDP platform. The driving program is self-contained; no programming languages or skills are needed.

APPLICATIONS INFORMATION

BIPOLAR OPERATION FROM DUAL SUPPLIES

The AD5235 can be operated from ± 2.5 V dual supplies, which enable control of ground referenced ac signals or bipolar operation. AC signals as high as V_{DD} and V_{SS} can be applied directly across Terminal A to Terminal B with the output taken from Terminal W. See Figure 47 for a typical circuit connection.

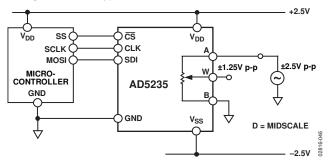


Figure 47. Bipolar Operation from Dual Supplies

GAIN CONTROL COMPENSATION

A digital potentiometer is commonly used in gain control such as the noninverting gain amplifier shown in Figure 48.

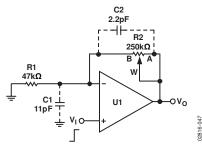


Figure 48. Typical Noninverting Gain Amplifier

When the RDAC B terminal parasitic capacitance is connected to the op amp noninverting node, it introduces a zero for the $1/\beta_0$ term with 20 dB/dec, whereas a typical op amp gain bandwidth product (GBP) has -20 dB/dec characteristics. A large R2 and finite C1 can cause the frequency of this zero to fall well below the crossover frequency. Therefore, the rate of closure becomes 40 dB/dec, and the system has a 0° phase margin at the crossover frequency. If an input is a rectangular pulse or step function, the output can ring or oscillate. Similarly, it is also likely to ring when switching between two gain values; this is equivalent to a stop change at the input.

Depending on the op amp GBP, reducing the feedback resistor might extend the frequency of the zero far enough to overcome the problem. A better approach is to include a compensation capacitor, C2, to cancel the effect caused by C1. Optimum compensation occurs when $R1 \times C1 = R2 \times C2$. This is not an option because of the variation of R2. As a result, one can use the previous relationship and scale C2 as if R2 were at its maximum value. Doing this might overcompensate and compromise the performance when R2 is set at low values.

Alternatively, it avoids the ringing or oscillation at the worst case. For critical applications, find C2 empirically to suit the oscillation. In general, C2 in the range of a few picofarads to no more than a few tenths of picofarads is usually adequate for the compensation.

Similarly, W and A terminal capacitances are connected to the output (not shown); their effect at this node is less significant and the compensation can be avoided in most cases.

HIGH VOLTAGE OPERATION

The digital potentiometer can be placed directly in the feedback or input path of an op amp for gain control, provided that the voltage across Terminal A to Terminal B, Terminal W to Terminal A or Terminal W to Terminal B does not exceed $|5\ V|$. When high voltage gain is needed, set a fixed gain in the op amp and let the digital potentiometer control the adjustable input. Figure 49 shows a simple implementation.

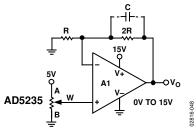


Figure 49. 15 V Voltage Span Control

Similarly, a compensation capacitor, C, may be needed to dampen the potential ringing when the digital potentiometer changes steps. This effect is prominent when stray capacitance at the inverted node is augmented by a large feedback resistor. Typically, a picofarad Capacitor C is adequate to combat the problem.

DAC

For DAC operation (see Figure 50), it is common to buffer the output of the digital potentiometer unless the load is much larger than R_{WB} . The buffer serves the purpose of impedance conversion and can drive heavier loads.

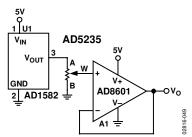


Figure 50. Unipolar 10-Bit DAC